CLAIMS

1. A coating thickness measuring instrument having a first mode of
operation in which the instruments operative to make measurements with a first
resolution and a second mode of operation in which the instrument is operative to
make measurements with a second resolution, the first resolution being greater than
the second resolution.

- 2. The instrument of claim 1, wherein when the instrument is in the first mode, the instrument is operative to make measurements in a first range and when the instrument is in the second mode, the instrument is operative to make measurements in a second range.
- 3. The instrument of claim 1, wherein when the instrument is in the first mode, the instrument is operative to make measurements in a first range at a high resolution and when the instrument is in the second mode, the instrument is operative to make measurements in a second range at a lower resolution, the second range being longer than the first range.
- 4. The instrument of claim 1, wherein when the instrument is in the first mode, the instrument is operative to make measurements in a first range and when the instrument is in the second mode, the instrument is operative to make measurements in a second range, such that the first range and the second range overlap.
- 5. The instrument of claim 1, further including an inductive probe comprising a drive coil, and two pickup coils.
 - 6. The instrument of claim 1, further including an inductive probe comprising a drive coil and two pickup coils; and



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	1		a means to drive an alternating current of substantially constant
	2	amplitude in t	
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100 J	1	7.	The instrument of claim 1, further including:
	2	,.	an inductive probe comprising a drive coil and two pickup coils; and
	3		a means to drive an alternating current of substantially constant
	4	amplitude in t	
	5	ampiitude iii t	wherein the means to drive an alternating current comprises an
	6	oscillator and	associated control loop circuit arranged to control the oscillator in
	7		oon current flowing in the drive coil.
	,	dependence u	bon current nowing in the drive con.
	1	0	The instrument of claim 1, further including:
	1	8.	
	2		an inductive probe comprising a drive coil and two pickup coils; and
	3		a means to drive an alternating current of substantially constant
	4	amplitude in t	he drive coil; and
	5		a means for varying the amplitude of alternating current flowing in the
	6	drive coil;	
	7		wherein the means to drive an alternating current comprises an
	8	oscillator and	associated control loop circuit arranged to control the oscillator in
	9	dependence u	oon current flowing in the drive coil.
	1	9.	The instrument of claim 8, wherein the means for varying the
	2	amplitude con	nprises a digitally controlled potentiometer.
	1	10.	The instrument of claim 1, further including:
	2		an inductive probe comprising a drive coil and two pickup coils; and
	3		a means for sensing variation in coupling between the drive and pickup
	1	coils and cons	verting the variation in counling to a thickness value

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11. The instrument of claim 1, further including:
an inductive probe comprising a drive coil and two pickup coils; and
a means for sensing variation in coupling between the drive and pickup
coils and converting this to a thickness value;

wherein said means for sensing comprises a differential amplifier, means for rectifying the output of the pickup coils and an analog to digital converter.

12. The instrument of claim 1, further including:

an inductive probe comprising a drive coil and two pickup coils; and a means for sensing variation in coupling between the drive and pickup coils and converting the variation in coupling to a thickness value, said means for sensing comprising a differential amplifier, means for rectifying the output of the pickup coils and an analog to digital converter;

wherein the means for rectifying comprises a synchronous detector controlled by a synchronizing signal derived from the means to drive an alternating current in the drive coil.

13. The instrument of claim 1, further including:
an inductive probe comprising a drive coil and two pickup coils; and
a means to modify the amplitude of current flowing in the drive coil
in dependence upon output from the pickup coils.

14. The instrument of claim 1, further including:

an inductive probe comprising a drive coil and two pickup coils; and a means to modify the amplitude of current flowing in the drive coil in dependence upon output from the pickup coils;

wherein the means to modify the amplitude comprises a control loop arranged to reduce the amplitude of current supplied to the drive coil as differential output of the pickup coils increases.

	1	15. The instrument of claim 1, further including:
	2	an inductive probe comprising a drive coil and two pickup coils;
	3	a means to modify the amplitude of current flowing in the drive coil
	4	in dependence upon output from the pickup coils; and
	5	a switch to enable the control loop to be switched in and out of
	6	operation, in order to switch the instrument between the first and second modes;
	7	wherein the means to modify the amplitude comprises a control loop
æ	8	arranged to reduce the amplitude of current supplied to the drive coil as differential
ا جا جا جا حاد	9	output of the pickup coils increases.
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	1	16. The instrument of claim 1, comprising:
Ū.	2	a microprocessor; and
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₽	3	a memory, the memory being operative to store look-up tables for both
	3 4	long and short range modes of operation and the microprocessor being operative to
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. O.wo	4	long and short range modes of operation and the microprocessor being operative to
	4	long and short range modes of operation and the microprocessor being operative to
	4 5	long and short range modes of operation and the microprocessor being operative to generate a coating thickness value using one of the look-up tables.
	4 5	long and short range modes of operation and the microprocessor being operative to generate a coating thickness value using one of the look-up tables. 17. A doating thickness measuring instrument, comprising:
	4 5 1 2	long and short range modes of operation and the microprocessor being operative to generate a coating thickness value using one of the look-up tables. 17. A coating thickness measuring instrument, comprising: an inductive probe having a drive coil and a pickup coil;
	1 2 3	long and short range modes of operation and the microprocessor being operative to generate a coating thickness value using one of the look-up tables. 17. A coating thickness measuring instrument, comprising: an inductive probe having a drive coil and a pickup coil; a means for driving an alternating current in the drive coil;
	1 2 3 4	long and short range modes of operation and the microprocessor being operative to generate a coating thickness value using one of the look-up tables. 17. A coating thickness measuring instrument, comprising: an inductive probe having a drive coil and a pickup coil; a means for driving an alternating current in the drive coil; a means for detecting the output of the pickup coil; and
	1 2 3 4 5	long and short range modes of operation and the microprocessor being operative to generate a coating thickness value using one of the look-up tables. 17. A coating thickness measuring instrument, comprising: an inductive probe having a drive coil and a pickup coil; a means for driving an alternating current in the drive coil; a means for detecting the output of the pickup coil; and a means for modifying the current in the drive coil in dependence upon
	1 2 3 4 5	long and short range modes of operation and the microprocessor being operative to generate a coating thickness value using one of the look-up tables. 17. A coating thickness measuring instrument, comprising: an inductive probe having a drive coil and a pickup coil; a means for driving an alternating current in the drive coil; a means for detecting the output of the pickup coil; and a means for modifying the current in the drive coil in dependence upon
	1 2 3 4 5 6	long and short range modes of operation and the microprocessor being operative to generate a coating thickness value using one of the look-up tables. 17. A coating thickness measuring instrument, comprising: an inductive probe having a drive coil and a pickup coil; a means for driving an alternating current in the drive coil; a means for detecting the output of the pickup coil; and a means for modifying the current in the drive coil in dependence upon the output of the pickup coil.

	1	19. The instrument of claim 18, wherein the means for modifying the	
and a	2	current in the drive soil comprises a first control loop which is switchable in and out	
	, 3	of operation to provide two modes of operation for the instrument and wherein the	
The state of	4	means for driving a current in the drive coil comprises a second control loop arranged	
U	5	to maintain the amplitude of current in the drive coil at a substantially constant level.	
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	1	20. The instrument of claim 17, wherein the means for modifying the	
	2	current in the drive coil comprises a first control loop which is switchable in and out	
	3	of operation to provide two modes of operation for the instrument and wherein the	
<u>o</u> o	4	means for driving comprises an amplitude controlled oscillator and the first control	
	5	loop is implemented by a current to voltage rectifier, a low pass filter and an error	
	6	amplifier.	
	1	21. The instrument of claim 17, wherein the means for modifying is	
I pu	2	arranged to modify the input to the error amplifier and the amplitude of the current in	
	3	the drive coil.	
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g	1	22. The instrument of claim 17, wherein the means for detecting the output	
	2	of the pickup coil comprises a synchronous detector.	

